

Application/Control No.	Applicant(s)/Patent under Reexamination
10/011,022	VANDERSLUIS, KIRSTAN ANDERSON
Examiner	Art Unit
David Y. Jung	2134

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Class	Subclass	Date	Examiner
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INT	ERFERENC	E SEARCH	ED
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
West, NPL, Internet	4/15/2005	DJ		
look at previously searched subclasses of US Patents	4/15/2005	חם		